EV372460781



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No
Filing Date June 21, 2001
Inventor Frank Melzer
Assignee Carl Zeiss SMT AG
Group Art Unit
Examiner R.D. Shafer
Attorney's Docket No LO25-003
Title: Method of Connecting a Multiplicity of Optical Elements to a Basic Body

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

References - - See attached Form PTO-1449

In compliance with 37 C.F.R. §§ 1.56, 1.97 and 1.98, your attention is directed to the references listed on the attached Form PTO-1449. No admission is made regarding whether all the submitted references are prior art.

Citation of these references is respectfully requested.

Respectfully submitted,

Date: 8-23-04

D. Brent Kenady Reg. No. 40,045 Wells St. John P.S.

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Spokane, WA 99201-3828

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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

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SERIAL NO. 09/888,214

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APPLICANT Frank Melzer et al. FILING DATE

June 21, 2001

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EXAMINER

DATE CONSIDERED

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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